





20V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)} Max	I _D Max @ T _A = +25°C (Note 5)	
	495 m $Ω$ @ V_{GS} = -4.5 V	-0.77A	
-20V	690mΩ @ V _{GS} = -2.5V	-0.67A	
	960mΩ @ V _{GS} = -1.8V	-0.57A	

Description and Applications

This MOSFET has been designed to minimize the on-state resistance (R_{DS(ON)}) yet maintain superior switching performance, which makes it ideal for high-efficiency power management applications.

Portable Electronics

Features and Benefits

- Footprint of Just 0.6mm²—13 Times Smaller Than SOT23
- Low Gate Threshold Voltage
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- ESD Protected Gate 3kV
- Qualified to AEC-Q101 Standards for High Reliability

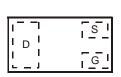
Mechanical Data

- Case: X1-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish—NiPdAu Over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (4)
- Weight: 0.001 grams (Approximate)

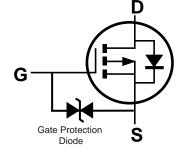




Bottom View



Top View Internal Schematic



Equivalent Circuit

Ordering Information (Note 4)

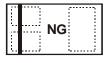
Part Number	Case	Packaging
DMP21D0UFB-7B	X1-DFN1006-3	10,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, see https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information

X1-DFN1006-3



Top View Bar Denotes Gate and Source Side

NG = Product Type Marking Code



Maximum Ratings (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V_{DSS}	-20	V
Gate-Source Voltage			V _{GSS}	±8	V
Continuous Drain Current	Steady State V _{GS} =-4.5V	$T_A = +25^{\circ}\text{C (Note 5)}$ $T_A = +85^{\circ}\text{C (Note 5)}$ $T_A = +25^{\circ}\text{C (Note 6)}$	I _D	-0.77 -0.55 -1.17	А
Pulsed Drain Current (Note 7)			I _{DM}	-5.0	Α

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	P _D	0.43	W
Thermal Resistance, Junction to Ambient (Note 5)	R _{OJA}	293	°C/W
Power Dissipation (Note 6)	P _D	0.99	W
Thermal Resistance, Junction to Ambient (Note 6)	R _{OJA}	126	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Thermal Characteristics

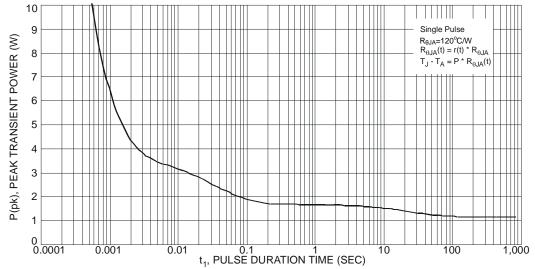


Fig. 1 Single Pulse Maximum Power Dissipation

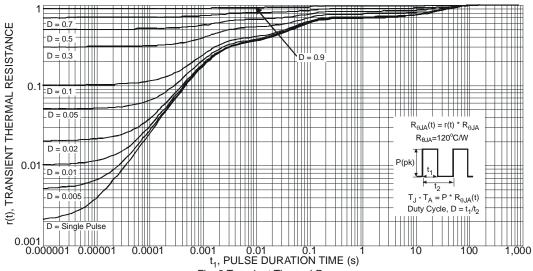


Fig. 2 Transient Thermal Response



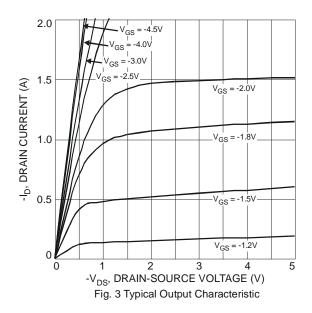
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

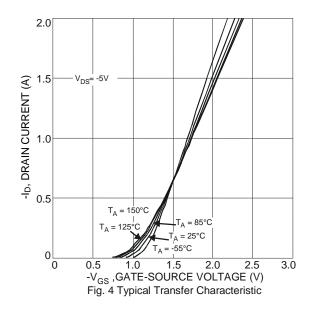
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	-20	l		V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current, T _J = +25°C	I _{DSS}		1	-1	μΑ	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 8V$, $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(TH)}	-0.5	-0.7	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
		_	_	495	mΩ	$V_{GS} = -4.5V, I_D = -400mA$	
Static Drain-Source On-Resistance	R _{DS(ON)}			690		$V_{GS} = -2.5V, I_D = -300mA$	
	, ,			960		$V_{GS} = -1.8V, I_D = -100mA$	
Forward Transfer Admittance	Y _{fs}	50	-	_	mS	$V_{DS} = -3V, I_{D} = -300 \text{mA}$	
Diode Forward Voltage	V _{SD}	-	-	-1.2	V	$V_{GS} = 0V, I_{S} = -300mA$	
DYNAMIC CHARACTERISTICS (Note 9)				•		•	
Input Capacitance	C _{iss}	_	76.5	_	рF	101/11/	
Output Capacitance	Coss	_	13.7	_	pF	$V_{DS} = -10V, V_{GS} = 0V,$	
Reverse Transfer Capacitance	C _{rss}	_	10.7	_	pF	f = 1.0MHz	
Gate Resistance	R_q	_	195	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge	Qq	_	1.5	_	nC	$V_{GS} = -8V, V_{DS} = -15V, I_{D} = -1A$	
Total Gate Charge	Qq	_	1.0	_	nC		
Gate-Source Charge	Q_{gs}	_	0.2	_	nC	$V_{GS} = -4.5V, V_{DS} = -15V,$	
Gate-Drain Charge	Q _{gd}	_	0.3	_	nC	I _D = -1A	
Turn-On Delay Time	t _{D(ON)}	_	7.1	_	ns	$V_{DS} = -10V, I_{D} = -1A$ $V_{GS} = -4.5V, R_{G} = 6\Omega$	
Turn-On Rise Time	t _R	_	8.0	_	ns		
Turn-Off Delay Time	t _{D(OFF)}	_	31.7	_	ns		
Turn-Off Fall Time	t _F	_	18.5	_	ns		

Notes:

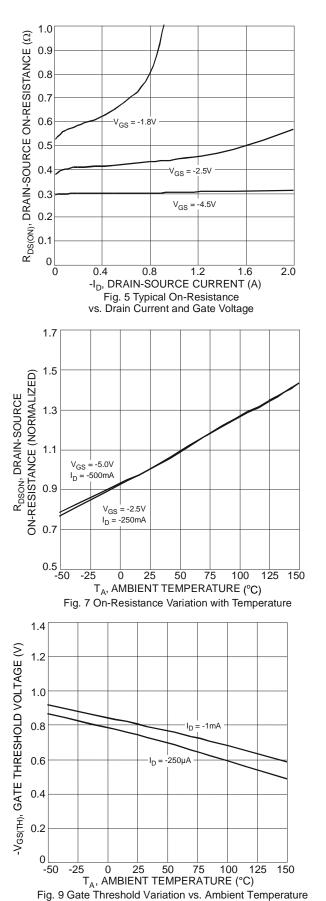
- 5. Device mounted on FR-4 substrate PCB, 2oz copper, with minimum recommended pad layout.6. Device mounted on FR-4 substrate PCB, 2oz copper, with thermal vias to bottom layer 1inch square copper plate.
- 7. Device mounted on minimum recommended pad layout test board, 10µs pulse duty cycle = 1%.
- 8. Short duration pulse test used to minimize self-heating effect.
- 9. Guaranteed by design. Not subject to product testing.

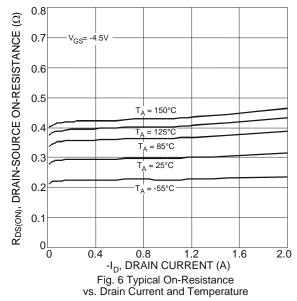
Typical Characteristics

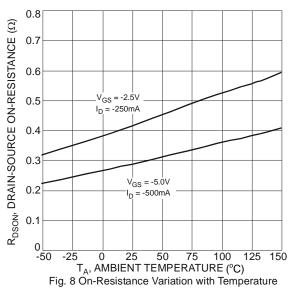


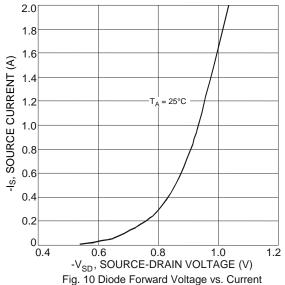




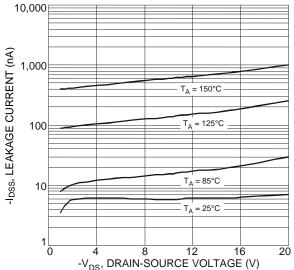




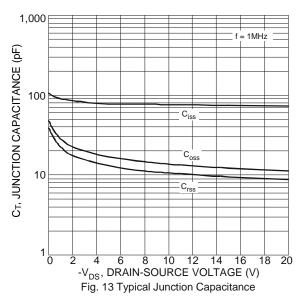


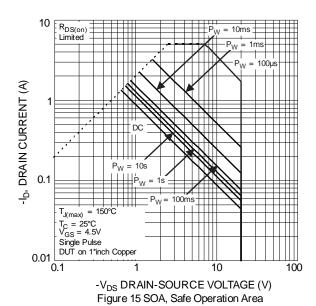


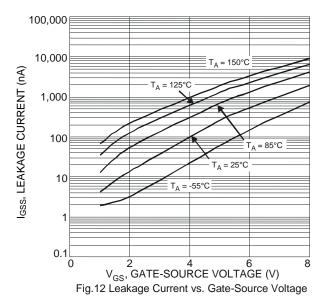


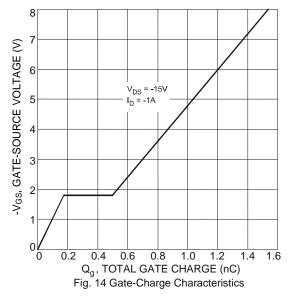










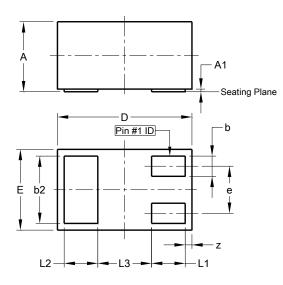




Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X1-DFN1006-3

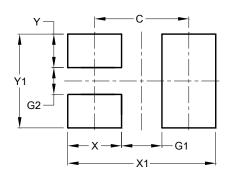


X1-DFN1006-3					
Dim	Min	Max	Тур		
Α	0.47	0.53	0.50		
A1	0.00	0.05	0.03		
b	0.10	0.20	0.15		
b2	0.45	0.55	0.50		
D	0.95	1.075	1.00		
Е	0.55	0.675	0.60		
е	-	-	0.35		
L1	0.20	0.30	0.25		
L2	0.20	0.30	0.25		
L3	-	-	0.40		
Z	0.02	0.08	0.05		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

X1-DFN1006-3



Dimensions	Value (in mm)
С	0.70
G1	0.30
G2	0.20
Х	0.40
X1	1.10
Y	0.25
Y1	0.70



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